Search Notes			

Application	/Control No.	Applicant(s)/Patent und Reexamination	er
10/010,738		ALIA ET AL.	
Examiner		Art Unit	
Tse Chen		2116	

SEARCHED				
Class	Subclass	Date	Examiner	
713	320	7/29/04	TSE	
713	601	7/29/04	TSE	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
713	320	6/24/05	TSt	
713	601	6/24/05	TSE	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
713/320,601 (TEXT SEARCH ONLY - SEE SEARCH HISTORY PRINTOUT)	7/29 - 8/2/64	TIE	
713/320,601 (PGPUB TEXT SEARCH — SEE INTERFERENCE SEARCH PRINTED)	6/24/05	TSE	